

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	169	bali.xa.	USPAT	OR	ON	2007/01/10 10:50
L2	198	bali.xp.	USPAT	OR	ON	2007/01/10 10:50
L3	367	1 2	USPAT	OR	ON	2007/01/10 10:50
L4	0	3 and inseption	USPAT	OR	ON	2007/01/10 10:50
L5	100	3 and inspection	USPAT	OR	ON	2007/01/10 10:50
L6	44	5 and wafer	USPAT	OR	ON	2007/01/10 10:51
L7	37	6 and defect	USPAT	OR	ON	2007/01/10 10:51
L8	24	7 and classif\$	USPAT	OR	ON	2007/01/10 11:03
L9	3512	382/141,144-145,149-151.ccls.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 11:04
L10	936	348/125,126,86,87.ccls.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 11:05
L12	2184809	wafer semiconductor pcb (printed adj (circuit board))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:10
L13	34193	12 near (inspect\$ defect detect\$)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:11
L14	812	13 same classif\$	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:13
L15	11	14 same candidat\$	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:15

## EAST Search History

L16	4086	9 10	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:15
L17	138	14 and 16	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:15
L18	0	14 same aggregat\$	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:15
L19	33	14 and aggregat\$	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:16
L20	38173	honda.in.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:16
L21	18738	okuda.in.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:17
L22	56809	20 21	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:17
L23	9	22 and (inspection same classif\$ same defect same compar\$)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/01/10 13:18